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INFORMATION DISCLOSURE CITATION

Atty. Docket No.	04329.2858-01	Div. of Serial No.	10/201,892	10/	668277
Applicant	Kei WATANABE, et al.		_		
Filing Date	Herewith	Prior Group:	2812	287	سهر

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Examiner	Michael	Trive	Date Considered	8/28/04		
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